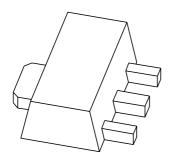
DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS5520X 20 V, 5 A PNP low V_{CEsat} (BISS) transistor

Product data sheet Supersedes data of 2004 Jun 23 2004 Nov 08



20 V, 5 A PNP low V_{CEsat} (BISS) transistor

PBSS5520X

FEATURES

- High h_{FE} and low V_{CEsat} at high current operation
- High collector current I_C: 5 A
- High efficiency leading to less heat generation.

APPLICATIONS

- Medium power peripheral drivers (e.g. fans and motors)
- Strobe flash units for digital still cameras and mobile phones
- · Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- · Battery chargers
- · Supply line switching.

DESCRIPTION

PNP low V_{CEsat} (BISS) transistor in a SOT89 (SC-62) plastic package.

NPN complement: PBSS4520X.

MARKING

TYPE NUMBER	MARKING CODE(1)
PBSS5520X	*1K

Note

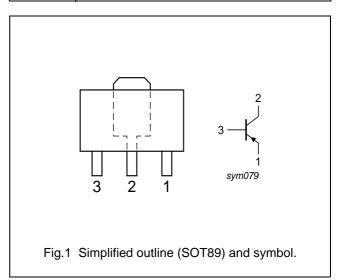
- 1. * = p: made in Hong Kong.
 - * = t: made in Malaysia.
 - * = W: made in China.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	-20	V
I _C	collector current (DC)	-5	Α
I _{CM}	peak collector current	-10	Α
R _{CEsat}	equivalent on-resistance	54	mΩ

PINNING

PIN	DESCRIPTION
1	emitter
2	collector
3	base



ORDERING INFORMATION

TYPE NUMBER		PACKAGE	
THE NOMBER	NAME DESCRIPTION		VERSION
PBSS5520X	SC-62 plastic surface mounted package; collector pad f good heat transfer; 3 leads		SOT89

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

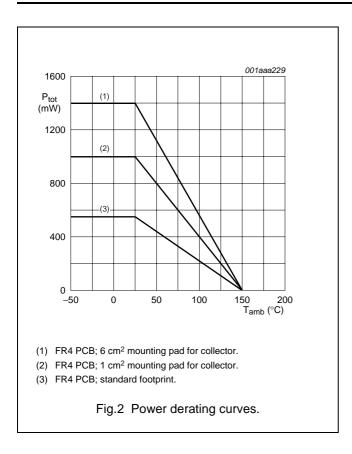
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	-	-20	V
V _{CEO}	collector-emitter voltage	open base	_	-20	V
V _{EBO}	emitter-base voltage	open collector	_	-5	V
I _C	collector current (DC)		_	-5	Α
I _{CM}	peak collector current	$t_p \le 1 \text{ ms}$	_	-10	Α
I _{CRP}	repetitive peak collector current	notes 1 and 2	_	-6.5	Α
I _B	base current (DC)		_	-1	Α
I _{BM}	peak base current	$t_p \le 1 \text{ ms}$	_	-2	Α
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C			
		notes 1 and 2	_	2.5	W
		note 2	_	0.55	W
		note 3	_	1	W
		note 4	_	1.4	W
		note 5	_	1.6	W
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C

Notes

- 1. Operated under pulsed conditions; pulse width $t_p \le 10$ ms; duty cycle $\delta \le 0.2$.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- $5. \quad \text{Device mounted on a 7 cm}^2 \text{ ceramic printed-circuit board, 1 cm}^2 \text{ single-sided copper, tin-plated.}$

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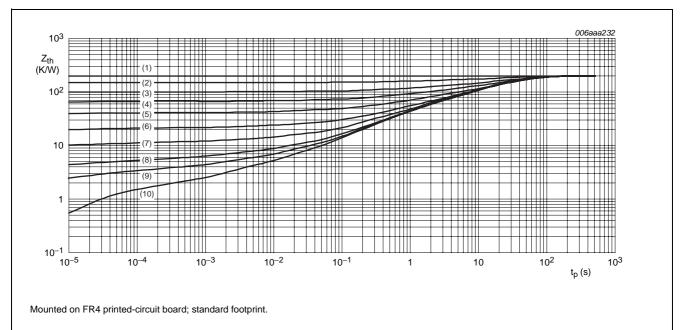
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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th(j-a)}	thermal resistance from junction to ambient	in free air		
		notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R _{th(j-s)}	thermal resistance from junction to soldering point		16	K/W

Notes

- 1. Operated under pulsed conditions; pulse width $t_p \le 10$ ms; duty cycle $\delta \le 0.2$.
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm².
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper, tin-plated.



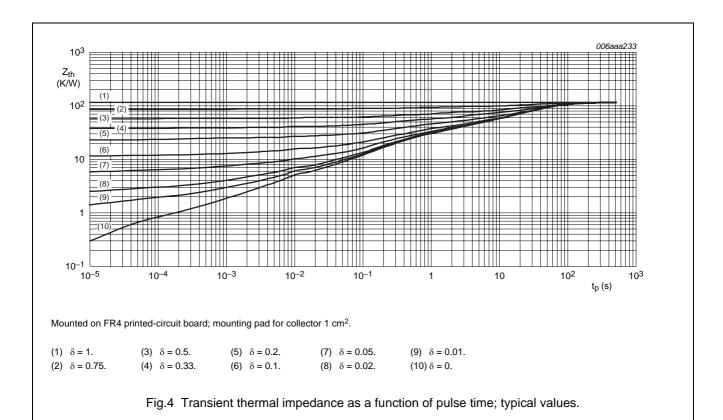
- (1) $\delta = 1$.
- (3) $\delta = 0.5$.
- (5) $\delta = 0.2$.
- (7) $\delta = 0.05$.
- (9) $\delta = 0.01$.

- (2) $\delta = 0.75$.
- (4) $\delta = 0.33$.
- (6) $\delta = 0.1$.
- (8) $\delta = 0.02$.
- (10) $\delta = 0$.

Fig.3 Transient thermal impedance as a function of pulse time; typical values.

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006aaa234 10³ Z_{th} (K/W) 10² (7) (8) (9) _(10¹ 10^{-1} 10-3 10³ 10 t_p (s) Mounted on FR4 printed-circuit board; mounting pad for collector 6 cm². (1) $\delta = 1$. (3) $\delta = 0.5$. (7) $\delta = 0.05$. (9) $\delta = 0.01$. (5) $\delta = 0.2$. (2) $\delta = 0.75$. (4) $\delta = 0.33$. (6) $\delta = 0.1$. (8) $\delta = 0.02$. (10) $\delta = 0$. Fig.5 Transient thermal impedance as a function of pulse time; typical values.

20 V, 5 A PNP low V_{CEsat} (BISS) transistor

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CHARACTERISTICS

 T_{amb} = 25 $^{\circ}C$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nA
		$V_{CB} = -20 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	-	_	-50	μΑ
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	_	-100	nA
I _{CES}	collector-emitter cut-off current	$V_{CE} = -20 \text{ V}; V_{BE} = 0 \text{ V}$	-	_	-100	nA
h _{FE}	DC current gain	V _{CE} = −2 V				
		I _C = −0.5 A; note 1	300	430	_	
		$I_C = -1$ A; note 1	275	400	_	
		$I_C = -2 A$; note 1	250	360	_	
		$I_C = -5$ A; note 1	150	260	_	
V _{CEsat}	collector-emitter saturation voltage	$I_C = -0.5 \text{ A}; I_B = -5 \text{ mA}$	_	-45	-70	mV
		$I_C = -1 \text{ A}; I_B = -10 \text{ mA}$	_	-70	-110	mV
		$I_C = -2.5 \text{ A}$; $I_B = -125 \text{ mA}$; note 1	-	-100	-150	mV
		$I_C = -4 \text{ A}$; $I_B = -200 \text{ mA}$; note 1	-	-150	-230	mV
		$I_C = -5 \text{ A}$; $I_B = -500 \text{ mA}$; note 1	-	-170	-270	mV
R _{CEsat}	equivalent on-resistance	$I_C = -5 \text{ A}$; $I_B = -500 \text{ mA}$; note 1	-	34	54	mΩ
V _{BEsat}	base-emitter saturation voltage	$I_C = -4 \text{ A}$; $I_B = -200 \text{ mA}$; note 1	-	-0.9	-1.05	V
		$I_C = -5 \text{ A}$; $I_B = -500 \text{ mA}$; note 1	-	-0.96	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	-	-0.74	-0.85	V
f _T	transition frequency	I _C = -100 mA; V _{CE} = -10 V; f = 100 MHz	80	100	_	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	_	130	150	pF

Note

1. Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

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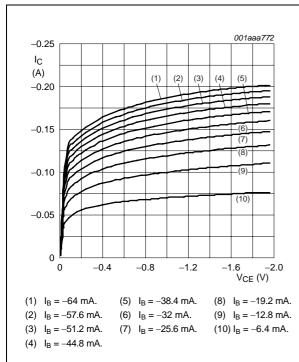
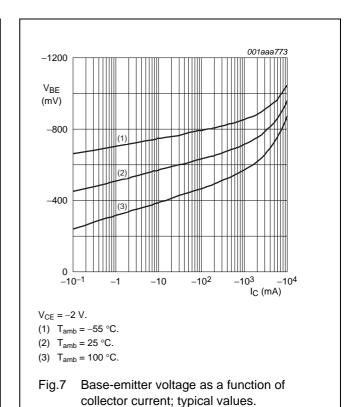
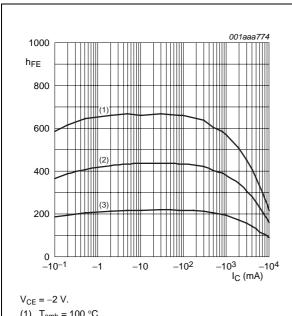


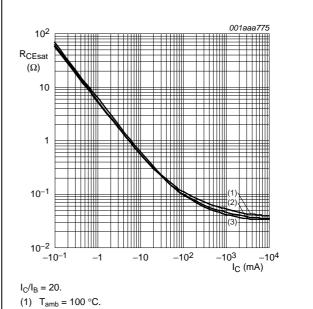
Fig.6 Collector current as a function of collector-emitter voltage; typical values.





- (1) $T_{amb} = 100 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.8 DC current gain as a function of collector current; typical values.



- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.9 Equivalent on-resistance as a function of collector current; typical values.

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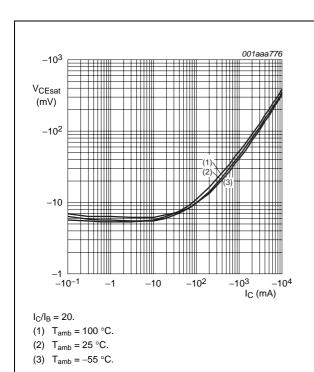


Fig.10 Collector-emitter saturation voltage as a function of collector current; typical values.

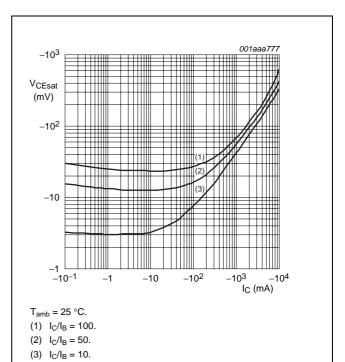
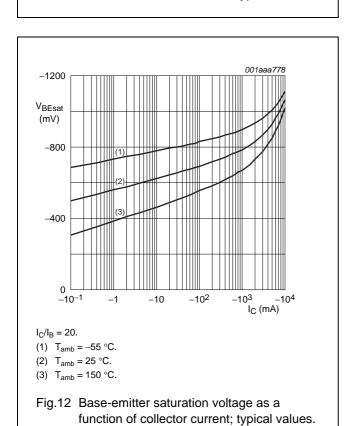
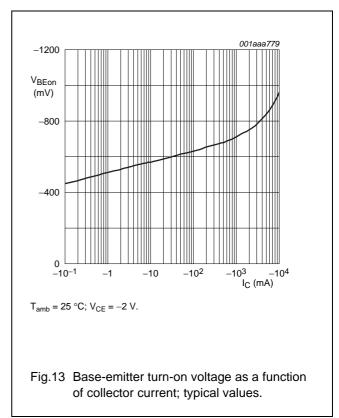


Fig.11 Collector-emitter saturation voltage as a

function of collector current; typical values.

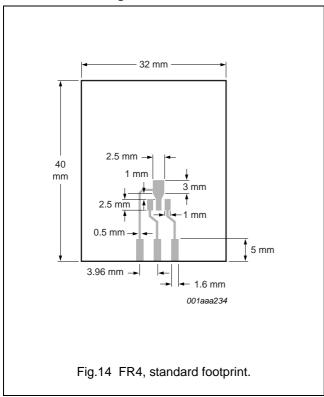


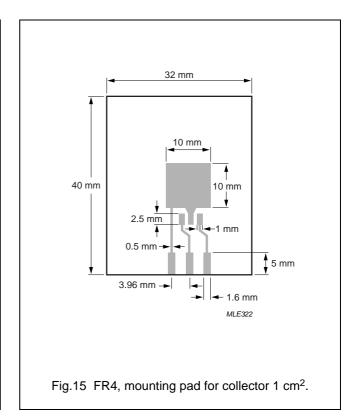


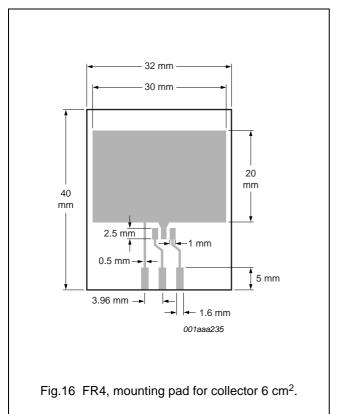
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Reference mounting conditions







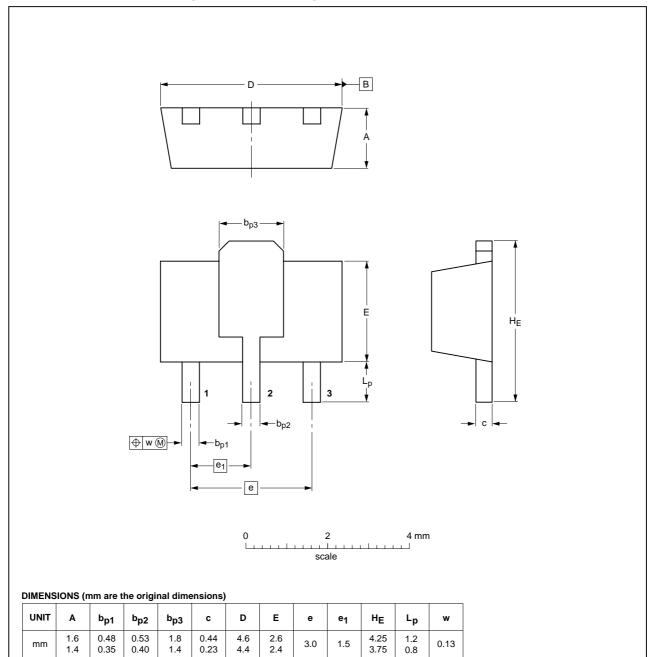
20 V, 5 A PNP low V_{CEsat} (BISS) transistor

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PACKAGE OUTLINE

Plastic surface-mounted package; collector pad for good heat transfer; 3 leads

SOT89



OUTLINE	OUTLINE REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT89		TO-243	SC-62			04-08-03 06-03-16

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DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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